

# E3M0900170J

1700V 900mΩ Silicon Carbide Power MOSFET  
N-Channel Enhancement Mode

## Features

- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- 12V...15V / 0V  $V_{GS}$  compatible with most flyback controllers
- Ultra-low drain-gate capacitance
- Halogen free, RoHS compliant
- Automotive qualified (AEC-Q101) and PPAP capable

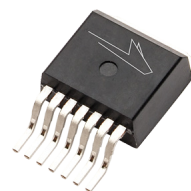
## Benefits

- Smooth switching waveforms
- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Increases system switching frequency
- Increases system reliability

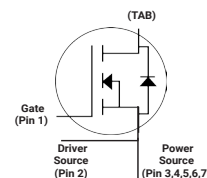
## Typical Applications

- Auxillary power supplies
- Switch Mode Power Supplies
- High-Voltage capacitive loads

## Package



TO-263-7



| Orderable Part Number | Package   | Marking     |
|-----------------------|-----------|-------------|
| E3M0900170J-TR        | TO-263-7L | E3M0900170J |

## Key Parameters

| Parameter                                  | Sym-<br>bol    | Min. | Typ.      | Max         | Unit             | Conditions                                                                         | Note    |
|--------------------------------------------|----------------|------|-----------|-------------|------------------|------------------------------------------------------------------------------------|---------|
| Drain - Source Voltage                     | $V_{DS}$       |      |           | 1700        | V                | $T_c = 25^\circ\text{C}$                                                           |         |
| Maximum Gate - Source Voltage (Transient)  | $V_{GS(max)}$  | -8   |           | +19         |                  | Transient                                                                          |         |
| Operational Turn-On Gate-Source Voltage    | $V_{GS op}$    |      | +12...+15 |             |                  | Static                                                                             |         |
| Operational Turn-Off Gate-Source Voltage   | $V_{GS op}$    |      | -4...0    |             |                  |                                                                                    |         |
| DC Continuous Drain Current                | $I_D$          |      |           | 4.4         | A                | $V_{GS} = 15\text{ V}, T_c = 25^\circ\text{C}, T_J \leq 175^\circ\text{C}$         | Note 2  |
|                                            |                |      |           | 3.3         |                  | $V_{GS} = 15\text{ V}, T_c = 100^\circ\text{C}, T_J \leq 175^\circ\text{C}$        |         |
| Pulsed Drain Current                       | $I_{DM}$       |      |           | 15          |                  | $t_{Pmax}$ limited by $T_{Jmax}$<br>$V_{GS} = 15\text{ V}, T_c = 25^\circ\text{C}$ | Fig. 22 |
| Power Dissipation                          | $P_D$          |      |           | 41          | W                | $T_c = 25^\circ\text{C}, T_J = 175^\circ\text{C}$                                  | Fig. 20 |
| Operating Junction and Storage Temperature | $T_J, T_{stg}$ |      |           | -55 to +175 | $^\circ\text{C}$ |                                                                                    |         |
| Solder Temperature                         | $T_L$          |      |           | 260         |                  |                                                                                    |         |

Note (1): Review application Note PRD-04814 for additional details

Note (2): Verified by design

**Electrical Characteristics** ( $T_c = 25^\circ\text{C}$  unless otherwise specified)

| Symbol        | Parameter                                     | Min. | Typ. | Max. | Unit          | Test Conditions                                                                                                                                                                                                                 | Note         |
|---------------|-----------------------------------------------|------|------|------|---------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------|
| $V_{(BR)DSS}$ | Drain-Source Breakdown Voltage                | 1700 |      |      | V             | $V_{GS} = 0\text{ V}, I_D = 100\text{ }\mu\text{A}$                                                                                                                                                                             |              |
| $V_{GS(th)}$  | Gate Threshold Voltage                        | 1.8  | 3.1  | 4.2  | V             | $V_{DS} = V_{GS}, I_D = 0.55\text{ mA}$                                                                                                                                                                                         | Fig. 11      |
|               |                                               |      | 2.6  |      | V             | $V_{DS} = V_{GS}, I_D = 0.55\text{ mA}, T_J = 175^\circ\text{C}$                                                                                                                                                                |              |
| $I_{DSS}$     | Zero Gate Voltage Drain Current               |      | 1    | 50   | $\mu\text{A}$ | $V_{DS} = 1700\text{ V}, V_{GS} = 0\text{ V}$                                                                                                                                                                                   |              |
| $I_{GSS}$     | Gate-Source Leakage Current                   |      | 10   | 250  | nA            | $V_{GS} = 15\text{ V}, V_{DS} = 0\text{ V}$                                                                                                                                                                                     |              |
| $R_{DS(on)}$  | Drain-Source On-State Resistance              |      | 900  | 1250 | m $\Omega$    | $V_{GS} = 15\text{ V}, I_D = 1.99\text{ A}$                                                                                                                                                                                     | Fig. 4, 5, 6 |
|               |                                               |      | 1938 |      |               | $V_{GS} = 15\text{ V}, I_D = 1.99\text{ A}, T_J = 175^\circ\text{C}$                                                                                                                                                            |              |
| $g_{fs}$      | Transconductance                              |      | 1    |      | S             | $V_{DS} = 20\text{ V}, I_{DS} = 1.99\text{ A}$                                                                                                                                                                                  | Fig. 7       |
|               |                                               |      | 1    |      |               | $V_{DS} = 20\text{ V}, I_{DS} = 1.99\text{ A}, T_J = 175^\circ\text{C}$                                                                                                                                                         |              |
| $C_{iss}$     | Input Capacitance                             |      | 202  |      | pF            | $V_{GS} = 0\text{ V}, V_{DS} = 0\text{ V to }1200\text{ V}$<br>$F = 100\text{ kHz}$<br>$V_{AC} = 25\text{ mV}$                                                                                                                  | Fig. 17, 18  |
| $C_{oss}$     | Output Capacitance                            |      | 8    |      |               |                                                                                                                                                                                                                                 |              |
| $C_{rss}$     | Reverse Transfer Capacitance                  |      | 1.4  |      |               |                                                                                                                                                                                                                                 |              |
| $E_{oss}$     | $C_{oss}$ Stored Energy                       |      | 8    |      | $\mu\text{J}$ |                                                                                                                                                                                                                                 | Fig. 16      |
| $C_{o(er)}$   | Effective Output Capacitance (Energy Related) |      | 10   |      | pF            | $V_{GS} = 0\text{ V}, V_{DS} = 0\text{ V to }1200\text{ V}$                                                                                                                                                                     | Note: 3      |
| $C_{o(tr)}$   | Effective Output Capacitance (Time Related)   |      | 13   |      | pF            |                                                                                                                                                                                                                                 |              |
| $E_{ON}$      | Turn-On Switching Energy (External Diode)     |      | 128  |      | $\mu\text{J}$ | $V_{DS} = 1200\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}, I_D = 1.99\text{ A},$<br>$R_{G(ext)} = 2.5\text{ }\Omega, L = 1707\text{ }\mu\text{H}, T_J = 175^\circ\text{C}$<br>FWD = External SiC DIODE                          | Fig. 26, 28  |
| $E_{OFF}$     | Turn Off Switching Energy (External Diode)    |      | 13   |      |               |                                                                                                                                                                                                                                 |              |
| $t_{d(on)}$   | Turn-On Delay Time                            |      | 20   |      | ns            | $V_{DD} = 1200\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}$<br>$I_D = 1.99\text{ A}, R_{G(ext)} = 2.5\text{ }\Omega, T_J = 175^\circ\text{C},$<br>$L = 1707\text{ }\mu\text{H}$<br>Timing relative to $V_{DS}$<br>Inductive load | Fig. 27, 28  |
| $t_r$         | Rise Time                                     |      | 16   |      |               |                                                                                                                                                                                                                                 |              |
| $t_{d(off)}$  | Turn-Off Delay Time                           |      | 20   |      |               |                                                                                                                                                                                                                                 |              |
| $t_f$         | Fall Time                                     |      | 42   |      |               |                                                                                                                                                                                                                                 |              |
| $R_{G(int)}$  | Internal Gate Resistance                      |      | 31   |      | $\Omega$      | $f = 1\text{ MHz}, V_{AC} = 25\text{ mV}$                                                                                                                                                                                       |              |
| $Q_{gs}$      | Gate to Source Charge                         |      | 4    |      | nC            | $V_{DS} = 1200\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}$<br>$I_D = 1.99\text{ A}$<br>Per IEC60747-8-4 pg 21                                                                                                                   | Fig. 12      |
| $Q_{gd}$      | Gate to Drain Charge                          |      | 2    |      |               |                                                                                                                                                                                                                                 |              |
| $Q_g$         | Total Gate Charge                             |      | 8    |      |               |                                                                                                                                                                                                                                 |              |

Note (3):  $C_{o(er)}$ , a lumped capacitance that gives same stored energy as  $C_{oss}$  while  $V_{ds}$  is rising from 0 to 1200V

$C_{o(tr)}$ , a lumped capacitance that gives same charging time as  $C_{oss}$  while  $V_{ds}$  is rising from 0 to 1200V

**Reverse Diode Characteristics ( $T_c = 25^\circ\text{C}$  unless otherwise specified)**

| Symbol    | Parameter                        | Typ. | Max. | Unit | Test Conditions                                                                                                                     | Note          |
|-----------|----------------------------------|------|------|------|-------------------------------------------------------------------------------------------------------------------------------------|---------------|
| $V_{SD}$  | Diode Forward Voltage            | 4.7  |      | V    | $V_{GS} = -4\text{ V}, I_{SD} = 1\text{ A}, T_J = 25^\circ\text{C}$                                                                 | Fig. 8, 9, 10 |
|           |                                  | 4.2  |      | V    | $V_{GS} = -4\text{ V}, I_{SD} = 1\text{ A}, T_J = 175^\circ\text{C}$                                                                |               |
| $I_S$     | Continuous Diode Forward Current | 6    |      | A    | $V_{GS} = -4\text{ V}, T_c = 25^\circ\text{C}$                                                                                      |               |
| $I_{SM}$  | Diode pulse Current              |      | 15   | A    | $V_{GS} = -4\text{ V}$ , pulse width $t_p$ limited by $T_{Jmax}$                                                                    |               |
| $t_{rr}$  | Reverse Recover time             | 22   |      | ns   | $V_{GS} = -4\text{ V}, I_{SD} = 1.99\text{ A}, V_R = 1200\text{ V}$<br>$dif/dt = 3710\text{ A}/\mu\text{s}, T_J = 25^\circ\text{C}$ |               |
| $Q_{rr}$  | Reverse Recovery Charge          | 50   |      | nC   |                                                                                                                                     |               |
| $I_{rrm}$ | Peak Reverse Recovery Current    | 5    |      | A    |                                                                                                                                     |               |
| $t_{rr}$  | Reverse Recover time             | 28   |      | ns   | $V_{GS} = -4\text{ V}, I_{SD} = 1.99\text{ A}, V_R = 1200\text{ V}$<br>$dif/dt = 1030\text{ A}/\mu\text{s}, T_J = 25^\circ\text{C}$ |               |
| $Q_{rr}$  | Reverse Recovery Charge          | 46   |      | nC   |                                                                                                                                     |               |
| $I_{rrm}$ | Peak Reverse Recovery Current    | 3    |      | A    |                                                                                                                                     |               |

**Thermal Characteristics**

| Symbol          | Parameter                                | Typ. | Max. | Unit                      | Test Conditions | Note    |
|-----------------|------------------------------------------|------|------|---------------------------|-----------------|---------|
| $R_{\theta JC}$ | Thermal Resistance from Junction to Case | 3.0  | 3.6  | $^\circ\text{C}/\text{W}$ |                 | Fig. 21 |

## Typical Performance

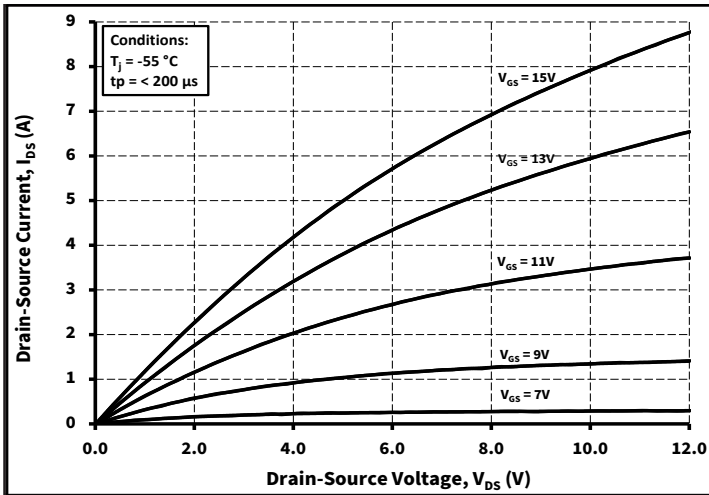
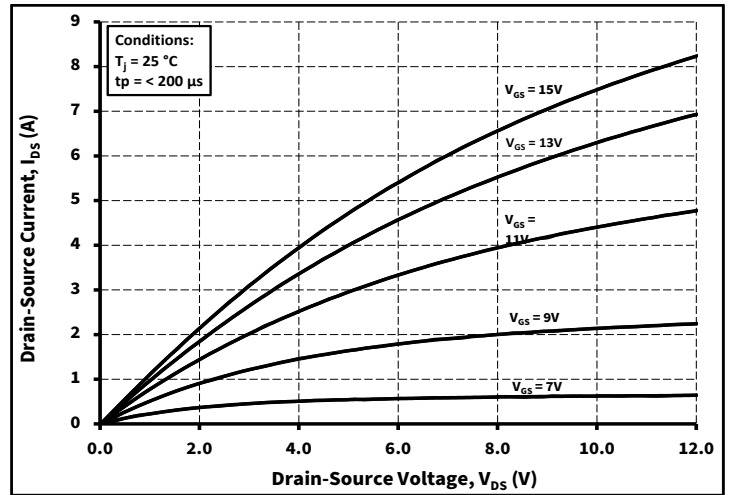
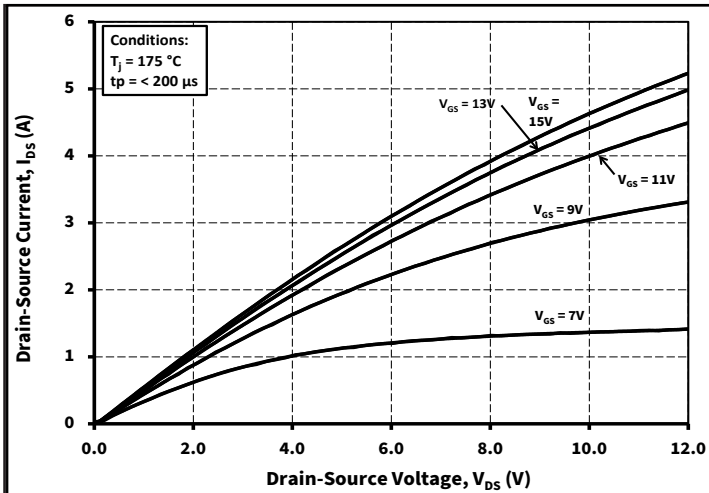
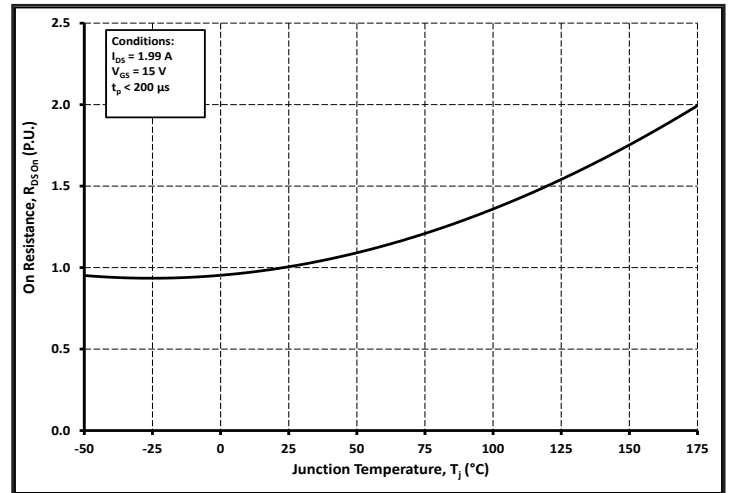
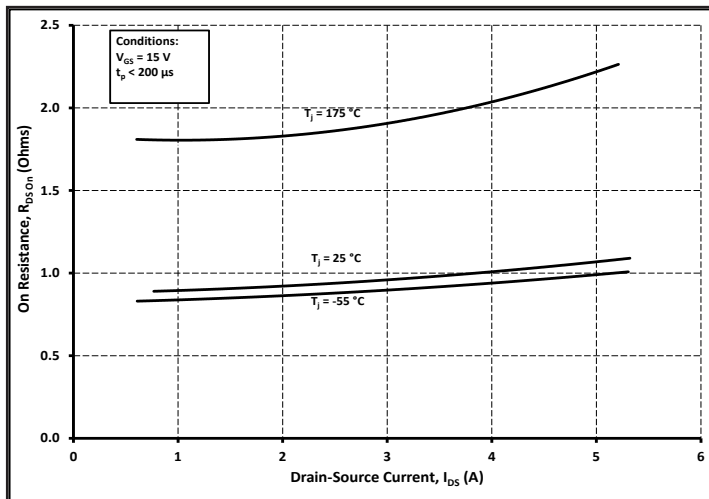
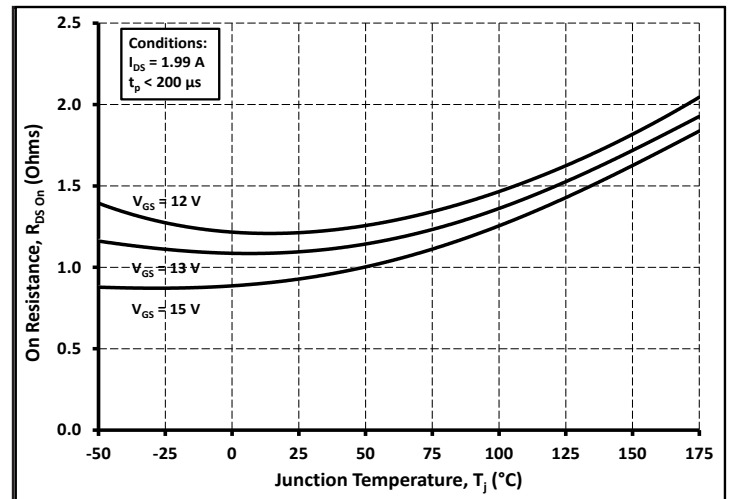
Figure 1. Output Characteristics  $T_J = -55\text{ }^{\circ}\text{C}$ Figure 2. Output Characteristics  $T_J = 25\text{ }^{\circ}\text{C}$ Figure 3. Output Characteristics  $T_J = 175\text{ }^{\circ}\text{C}$ 

Figure 4. Normalized On-Resistance vs. Temperature

Figure 5. On-Resistance vs. Drain Current  
For Various TemperaturesFigure 6. On-Resistance vs. Temperature  
For Various Gate Voltage

## Typical Performance

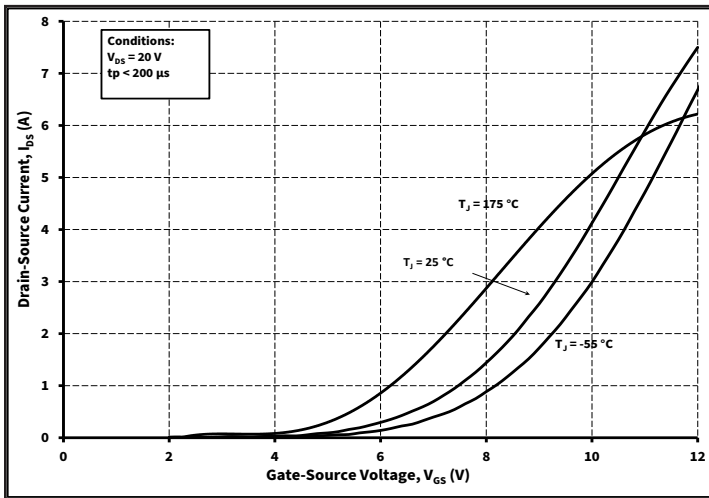


Figure 7. Transfer Characteristic for Various Junction Temperatures

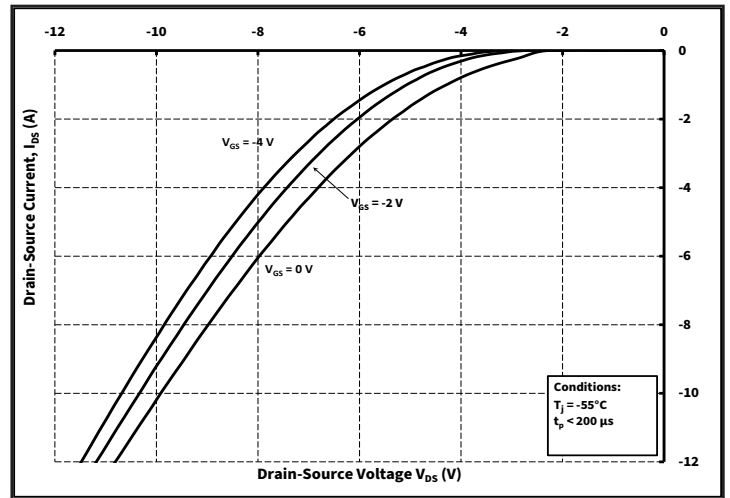


Figure 8. Body Diode Characteristic at -55 °C

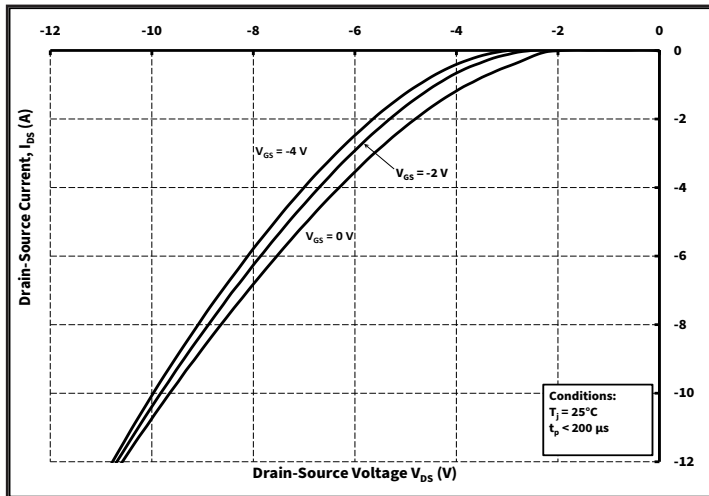


Figure 9. Body Diode Characteristic at 25 °C

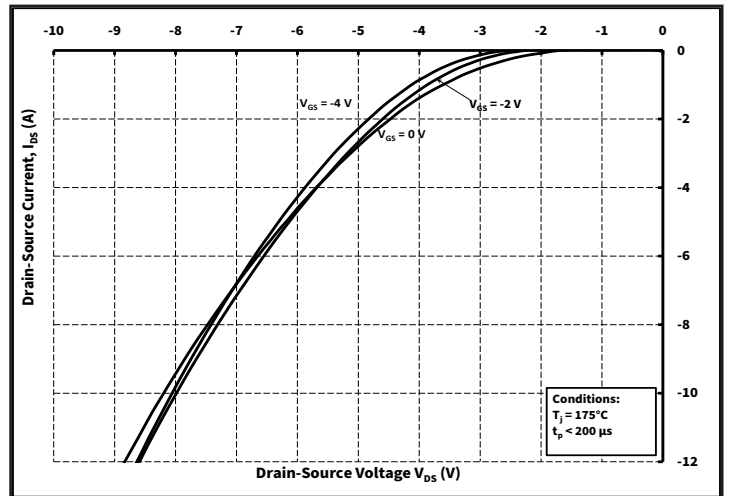


Figure 10. Body Diode Characteristic at 175 °C

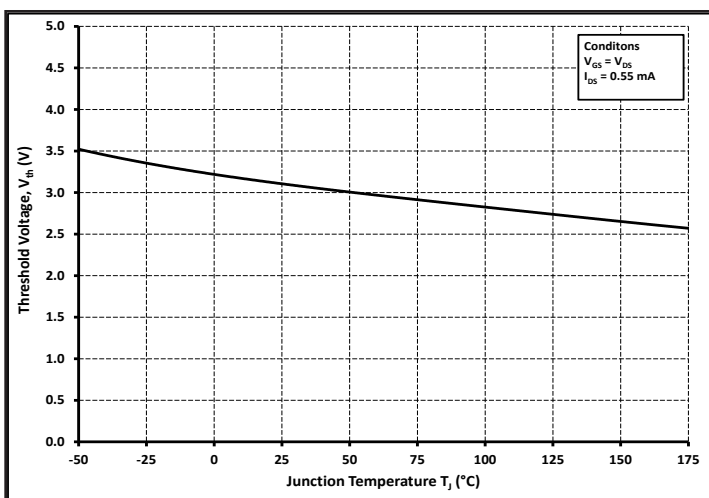


Figure 11. Threshold Voltage vs. Temperature

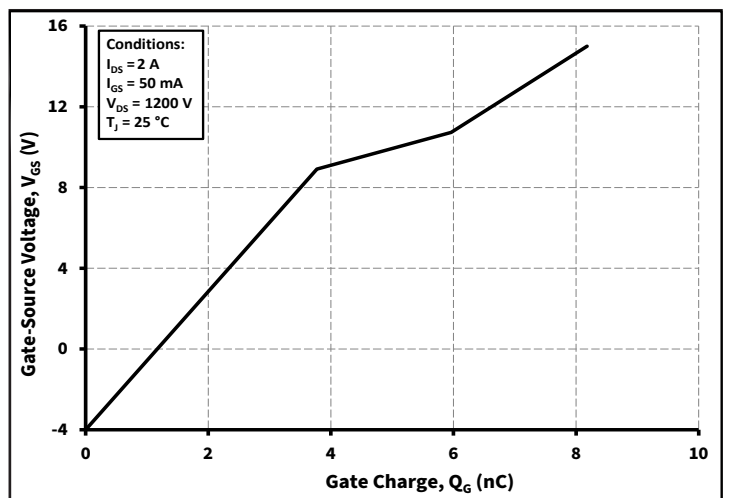


Figure 12. Gate Charge Characteristics

## Typical Performance

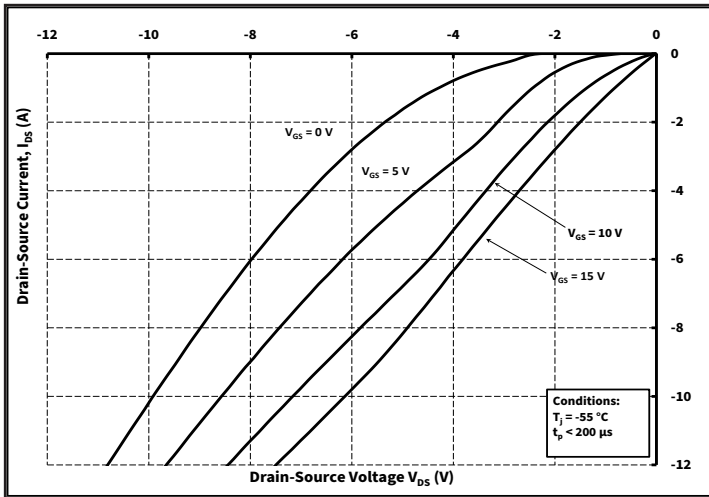
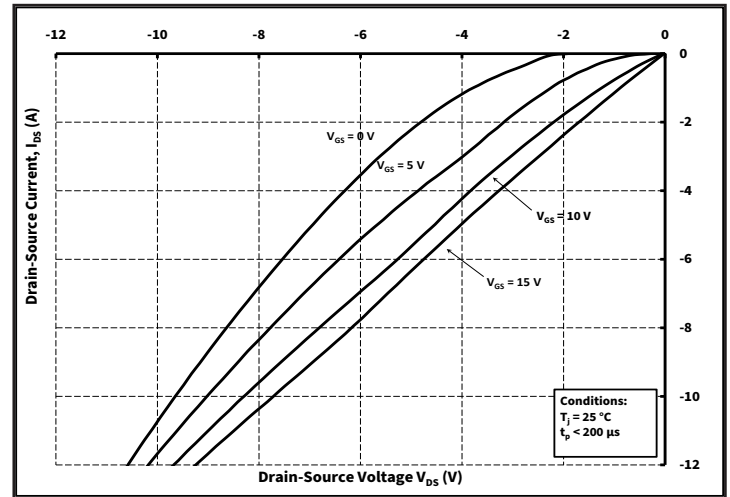
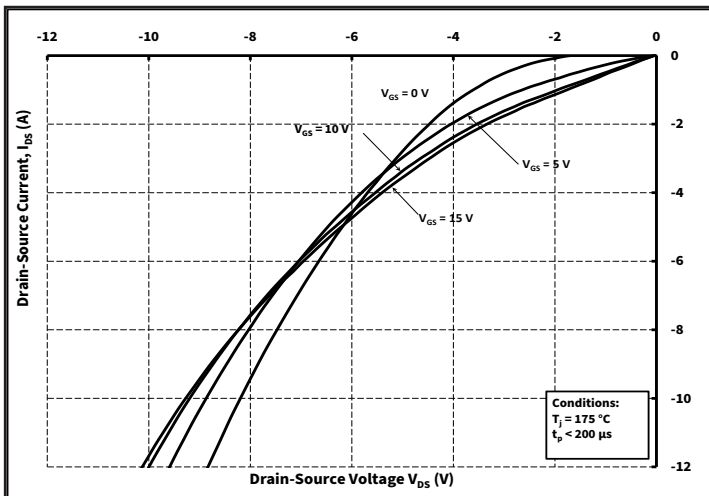
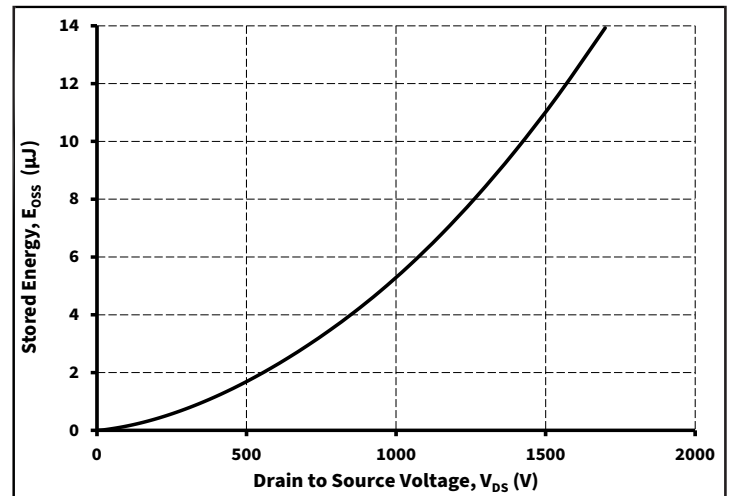
Figure 13. 3rd Quadrant Characteristic at  $-55^{\circ}\text{C}$ Figure 14. 3rd Quadrant Characteristic at  $25^{\circ}\text{C}$ Figure 15. 3rd Quadrant Characteristic at  $175^{\circ}\text{C}$ 

Figure 16. Output Capacitor Stored Energy

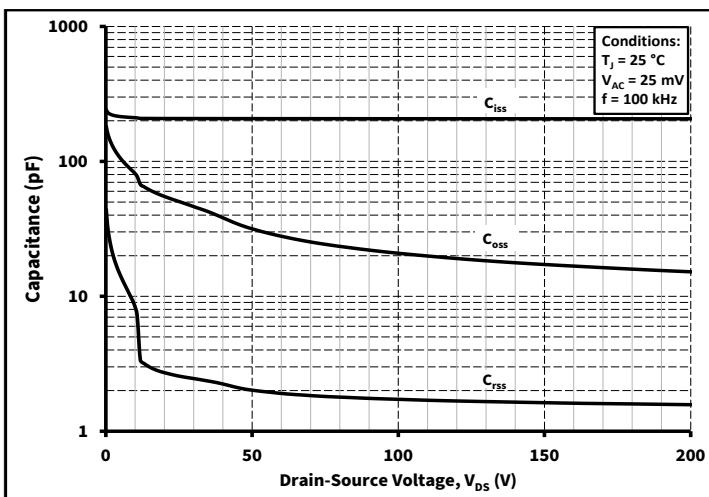


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

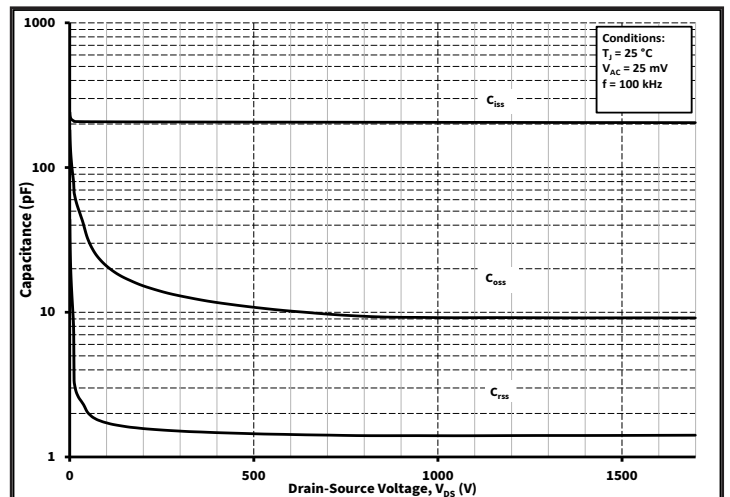


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1700V)

## Typical Performance

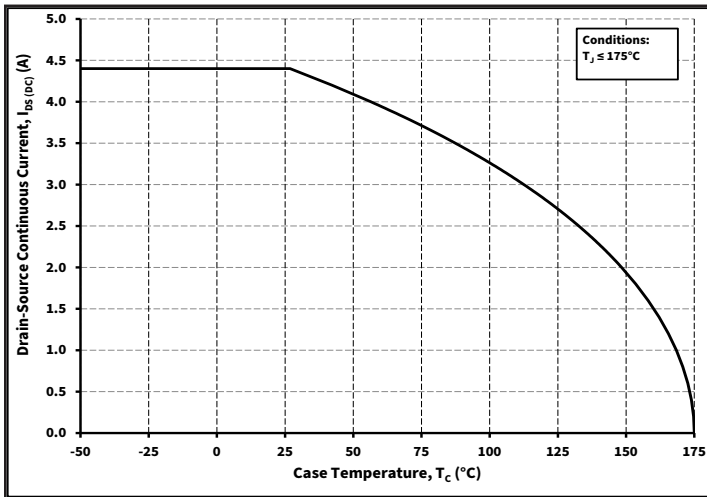


Figure 19. Continuous Drain Current Derating vs. Case Temperature

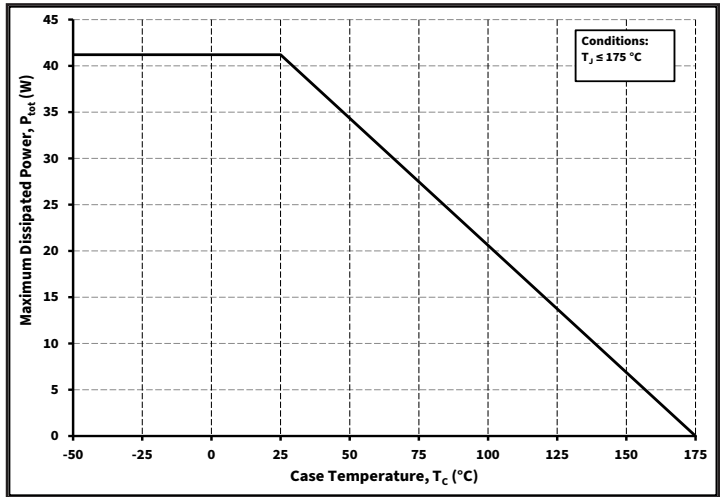


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

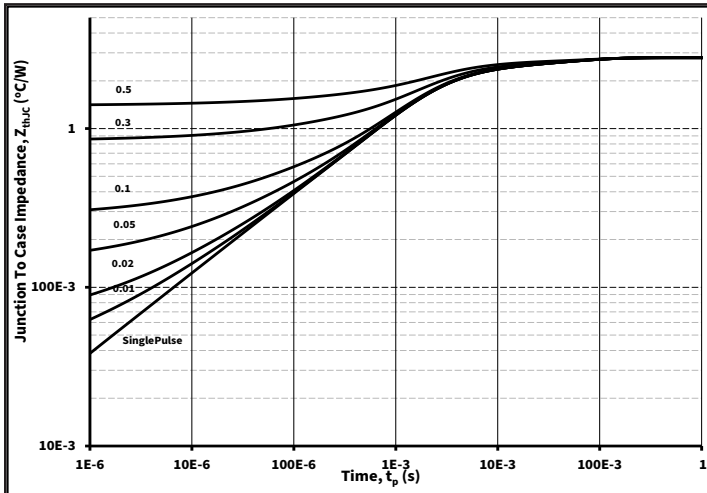


Figure 21. Transient Thermal Impedance (Junction - Case)

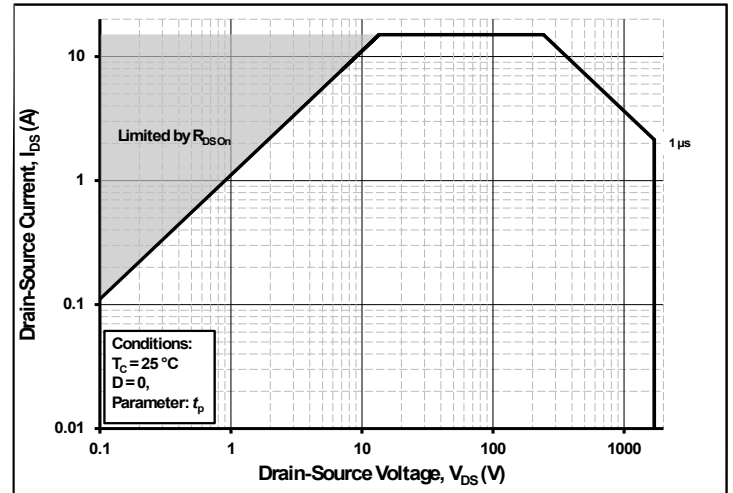


Figure 22. Safe Operating Area

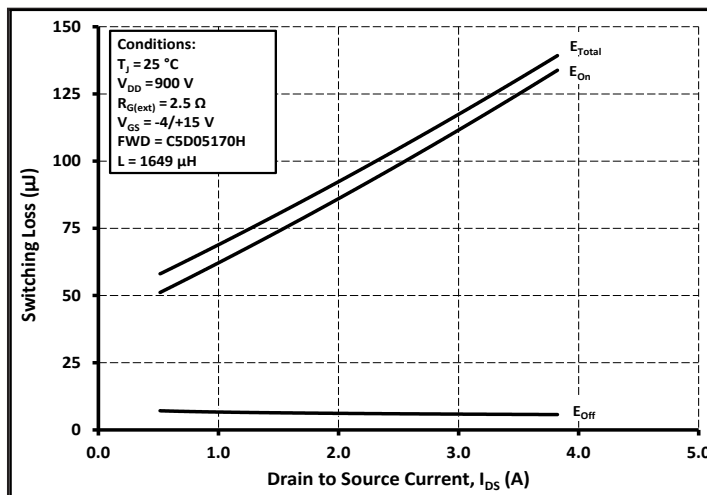


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD} = 900V$ )

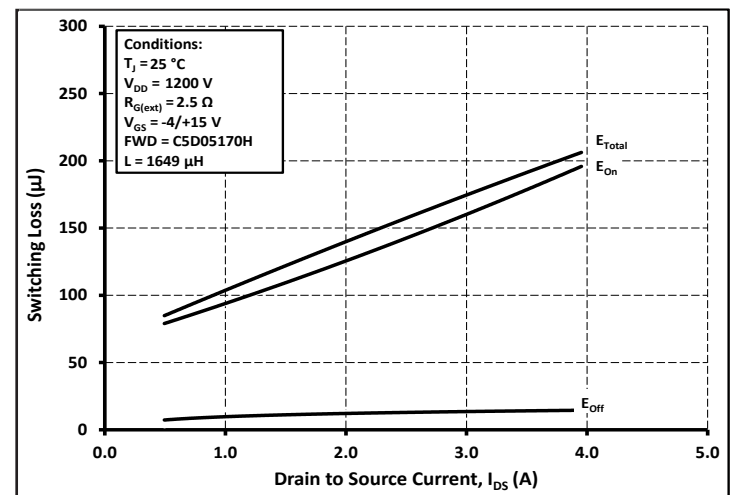


Figure 24. Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD} = 1200V$ )

## Typical Performance

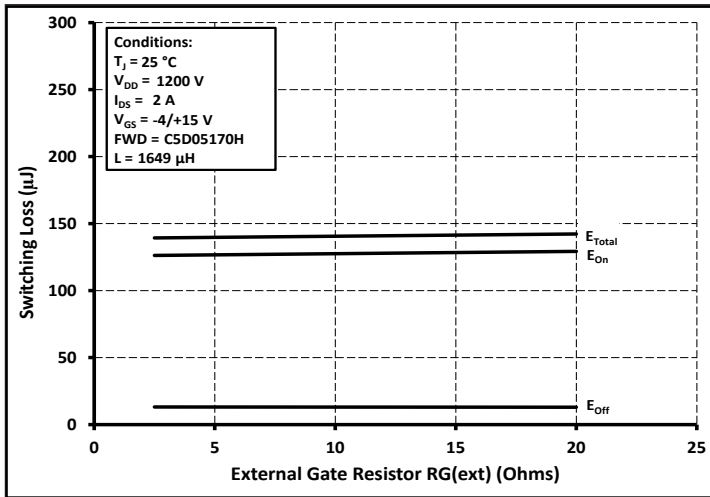


Figure 25. Clamped Inductive Switching Energy vs.  $R_{G(\text{ext})}$

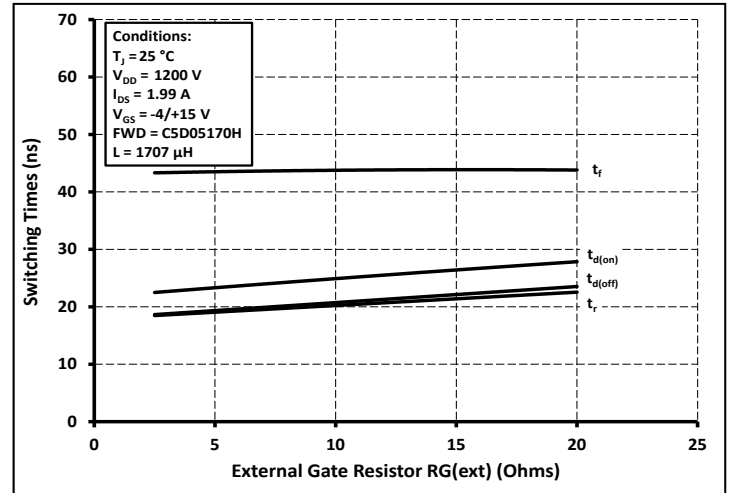


Figure 26. Switching Times vs.  $R_{G(\text{ext})}$

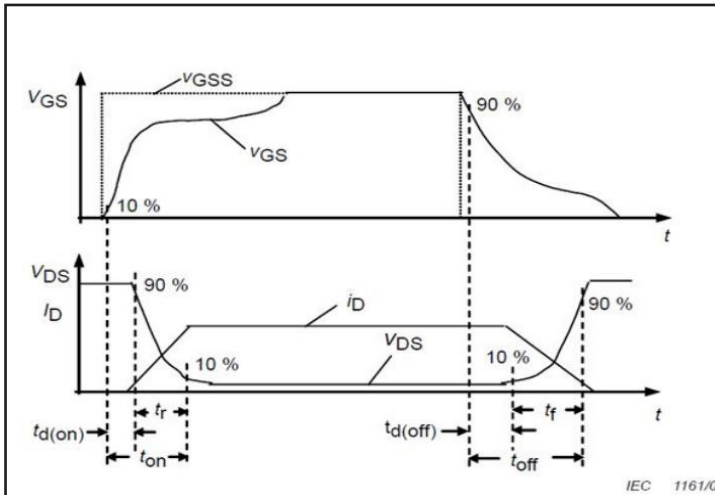


Figure 27. Switching Times Definition

## Test Circuit Schematic

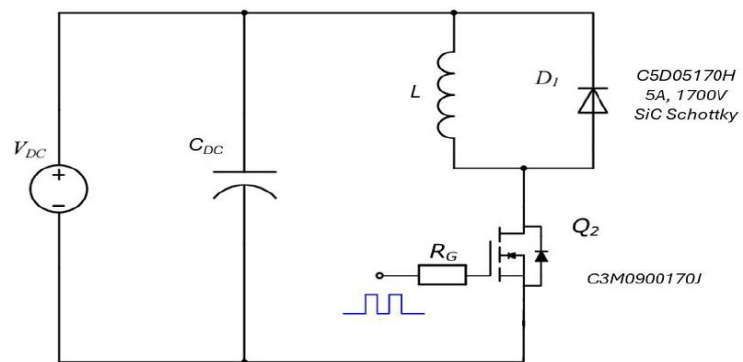
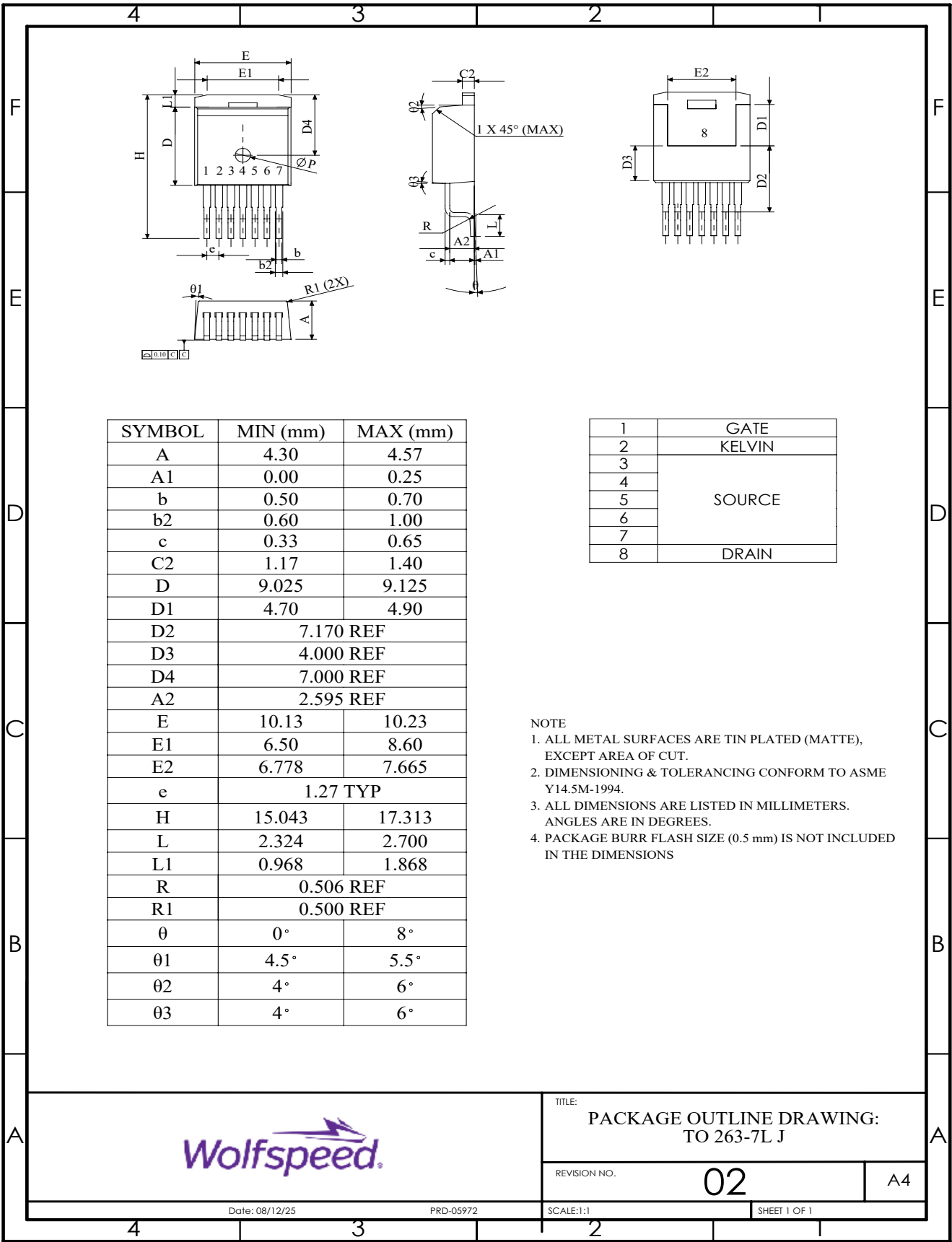


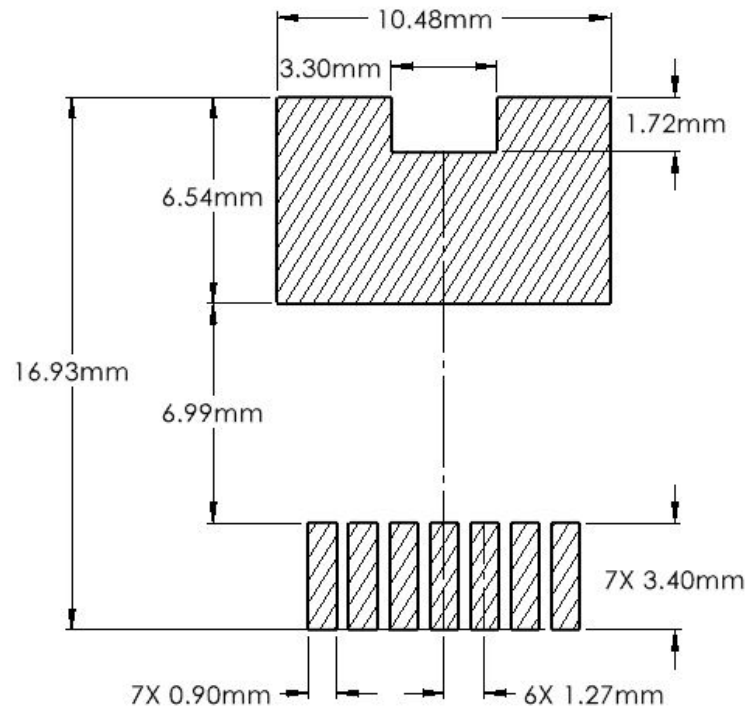
Figure 28. Clamped Inductive Switching  
Waveform Test Circuit

Package Dimensions



**Recommended Solder Pad Layout**

All dimensions in mm





**Revision history**

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| Document Version | Date of release  | Description of changes                          |
|------------------|------------------|-------------------------------------------------|
| 1                | March - 2025     | Initial Release                                 |
| 2                | September - 2025 | Package drawing updated to correct dimension D1 |

## Notes & Disclaimer

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